


<b>Search Notes</b> 	<b>Application/Control No.</b> 10537501	<b>Applicant(s)/Patent Under Reexamination</b> HEUER ET AL.
	<b>Examiner</b> WILSON TSUI	<b>Art Unit</b> 2178

SEARCHED			
Class	Subclass	Date	Examiner
715	234, 237, 242	04/23/09	/WT/
370	394	04/23/09	/WT/

SEARCH NOTES		
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Updated East Search: USPAT, USPGPUB See Notes	04/23/09	/WT/

INTERFERENCE SEARCH			
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